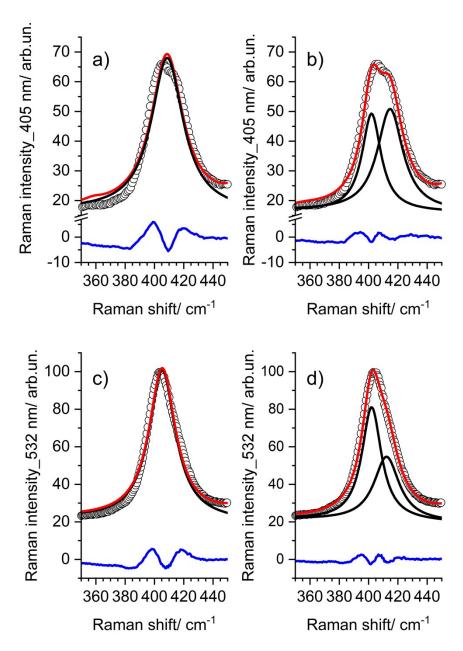
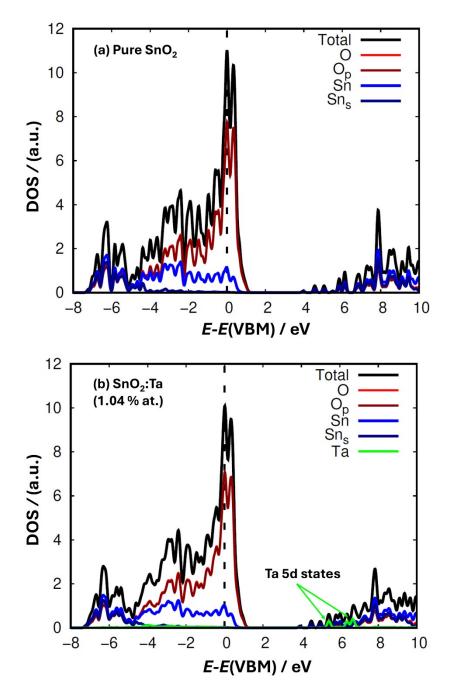
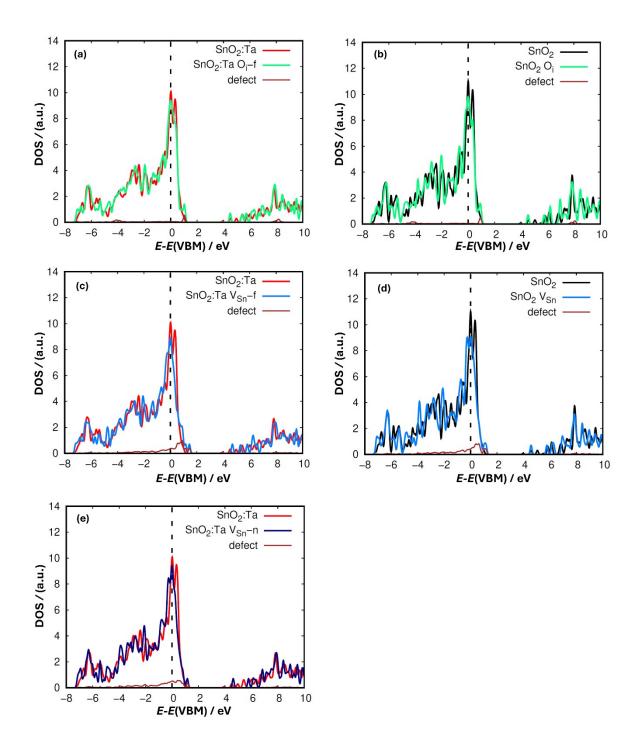
## **Supporting information**



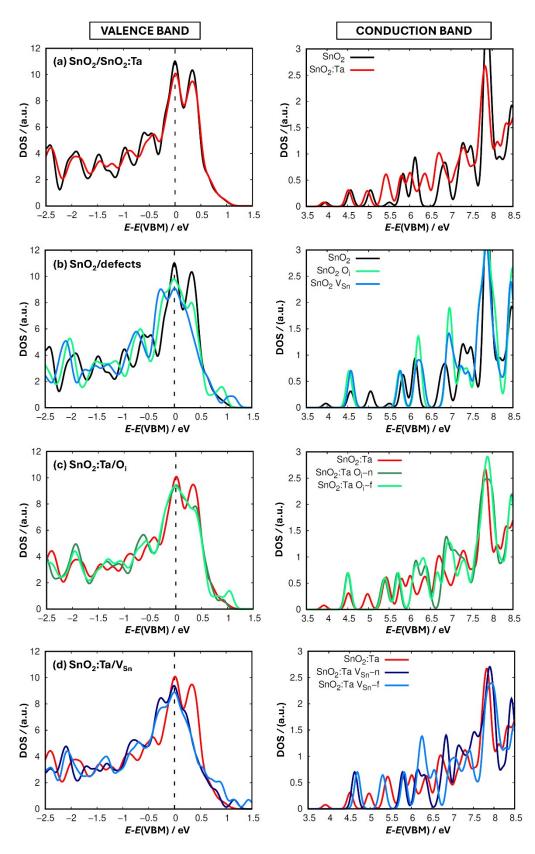
SI 1: Comparison of spectra fits for the  $D_1$  line spectral range measured with two different laser lines. a) one Lorentzian line fit, 405 nm excitation, b) two Lorentzian line fit, 405 nm excitation, c) one Lorentzian line fit, 532 nm excitation, d) two Lorentzian line fit, 532 nm excitation. Measured data ( $\circ$ ), Cumulative fits (red lines), individual line fits (black lines), fit residue (blue lines).



SI 2: Calculated DOS and PDOS of pure  $SnO_2$  (a) and  $SnO_2$ :Ta (1.04 % at.) showing the contribution of O 2porbitals and Sn s-orbitals.



SI 3: Calculated total and defect density of states of  $SnO_2$  and  $SnO_2$ : Ta without and with additional point defects. (a)  $SnO_2$ : Ta with and without  $O_i$ -far defect; (b)  $SnO_2$  with and without  $O_i$  defect; (c)  $SnO_2$ : Ta with and without  $V_{Sn}$ -far defect; (d)  $SnO_2$  with and without  $V_{Sn}$ -close defect.



SI 4: Enlarged VBM and the CBM regions of the density of states of  $SnO_2$  and  $SnO_2$ : Ta without and with additional point defects.

No.	File name	Model structure	Raman line
1	D1_SnO2-Ta_V-Sn-far	SnO <sub>2</sub> :Ta_V-Sn-far	D <sub>1</sub>
2	D1_SnO2-Ta_V-Sn-near	SnO <sub>2</sub> :Ta_V-Sn-near	D <sub>1</sub>
3	D2_SnO2-Ta_V-Sn-near	SnO <sub>2</sub> :Ta_V-Sn-near	D <sub>2</sub>
4	D2_SnO2-Ta_O-i-far	SnO <sub>2</sub> :Ta_O-i-far	$D_2$
5	L4SnO2-Ta_O-i-far	SnO <sub>2</sub> :Ta_O-i-far	$L_4$
6	L5_SnO2-Ta_O-i-far	SnO <sub>2</sub> :Ta_O-i-far	$L_5$

SI 5: xyz-files for the visualization of the characteristic vibrational modes responsible for the characteristic Raman lines  $D_1$ ,  $D_2$ ,  $L_4$ , and  $L_5$  of  $SnO_2$ : Ta (1.25 at.% Ta) thin films.